What is claimed is:

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- A semiconductor fabrication system, comprising:
 an air-tight housing in which an inert gas is admittable and exhaustible; and
- 5 a plurality of deposition chambers positioned within the system.
 - 2. The system of claim 1, wherein one of the deposition chambers is a facing target sputtering.
- 3. The system of claim 2, wherein the deposition chamber further comprises:

 a pair of target plates placed at opposite ends of said air-tight chamber

respectively so as to face each other and form a plasma region therebetween;

a pair of magnets respectively disposed adjacent to said target plates such that magnet poles of different polarities face each other across said plasma region thereby to establish a magnetic field of said plasma region between said target plates;

a substrate holder disposed adjacent to said plasma region, said substrate holder adapted to hold a substrate on which an alloyed thin film is to be deposited; and a back-bias power supply coupled to the substrate holder.

- 4. A facing targets sputtering device according to claim 3, wherein the back-bias power supply is a DC or an AC electric power source.
- 5. A facing targets sputtering device according to claim 1, further comprising a robot armto move the wafer.
 - 6. A facing targets sputtering device according to claim 1, further comprising a magnetron coupled to the chamber.
- 7. A facing targets sputtering device according to claim 1, further comprising a chuck heater mounted above the wafer.
 - 8. The apparatus of claim 1, further comprising a rotary chuck to move a wafer.
- 8. The apparatus of claim 1, further comprising a linear motor to move the rotary chuck and sequentially expose the wafer to a plurality of chambers.
 - 10. The apparatus of claim 1, wherein each chamber provides a collimated deposition pattern.

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- 11. The apparatus of claim 1, wherein each chamber further comprises a door that opens during each chamber's deposition and closes when the chamber is not depositing.
- 12. The apparatus of claim 11, wherein each door comprises a baffle to catch fallingparticulates.
 - 13. The apparatus of claim 1, wherein the chambers share magnets.
- 14. The apparatus of claim 1, further comprising a housing pump to evacuate air from thehousing.
 - 15. The apparatus of claim 1, wherein each chamber further comprises a chamber pump.
- 16. The apparatus of claim 1, further comprising chuck supported from underneath ratherthan from the side.
 - 17. The apparatus of claim 1, further comprising a jointed pendulum to support the wafer and keep the wafer at a constant vertical distance from the target as the pendulum swings.
- 20 18. A method for sputtering a thin film onto a substrate, comprising:

providing a plurality of deposition chambers, each having at least one target and a substrate having a film-forming surface portion and a back portion;

creating a magnetic field so that the film-forming surface portion is placed in the magnetic field with the magnetic field induced normal to the substrate surface portion back-biasing the back portion of the substrate; and sputtering material onto the film-forming surface portion.

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- 19. A method as in claim 18, further comprising swinging the wafer using a pendulum.
- 20. A method as in claim 18, further comprising supporting a chuck from underneath rather than side-way.